Vishay Siliconix

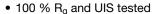
N-Channel 30 V (D-S) MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	30			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 10 \text{ V}$	0.00120			
$R_{DS(on)}$ max. (Ω) at $V_{GS} = 4.5 \text{ V}$	0.00185			
Q _g typ. (nC)	28.7			
I _D (A)	80 a, g			
Configuration	Single			

FEATURES

- TrenchFET® Gen IV power MOSFET
- Excellent R_{DS} Q_g Figure-of-Merit (FOM) for switch-mode power supplies



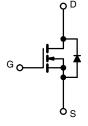
· Material categorization: for definitions of compliance please see www.vishay.com/doc?99912



RoHS COMPLIANT HALOGEN **FREE**

APPLICATIONS

- Synchronous buck converter
- High power density DC/DC
- · Synchronous rectification
- · Load switch
- OR-ing



N-Channel MOSFET

ORDERING INFORMATION	
Package	PowerPAK SO-8
Lead (Pb)-free and halogen-free	SiRA62DP-T1-RE3

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
PARAMETER		SYMBOL	LIMIT	UNIT	
Drain-source voltage		V _{DS}	30	V	
Gate-source voltage		V_{GS}	+16 / -12	V	
Continuous drain current (T _J = 150 °C)	T _C = 25 °C		80 a		
	T _C = 70 °C	1 , [80 ^a		
	T _A = 25 °C	† I _D	51.4 ^{b, c}		
	T _A = 70 °C		40.9 b, c	A	
Pulsed drain current (t = 100 μs)		I _{DM}	300	^	
Continuous source-drain diode current	T _C = 25 °C		59.7		
	T _A = 25 °C	T _A = 25 °C	4.7 ^{b, c}		
Single pulse avalanche current	L = 0.1 mH	I _{AS}	30		
Single pulse avalanche energy		E _{AS}	45	mJ	
Maximum power dissipation	T _C = 25 °C		65.7		
	T _C = 70 °C	7 5	42	w	
	T _A = 25 °C	P _D	5.2 ^{, c}	VV	
	T _A = 70 °C] [3.3 b, c		
Operating junction and storage temperature range		T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) ^c			260		

THERMAL RESISTANCE RATINGS						
PARAMETER		SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient ^b	t ≤ 10 s	R _{thJA}	20	24	°C/W	
Maximum junction-to-case (drain)	Steady state	R _{thJC}	1.5	1.9	7 0/00	

Notes

- Package limited
- b. Surface mounted on 1" x 1" FR4 board
- See solder profile (www.vishay.com/doc?73257). The PowerPAK 1212-8 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection

 Rework conditions: manual soldering with a soldering iron is not recommended for leadless components

 Maximum under steady state conditions is 62.5 °C/W

- $T_C = 25 \,^{\circ}C$

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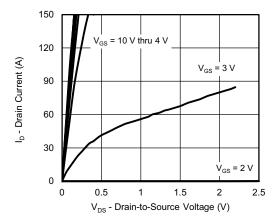
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static						
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	I _D =10 mA	-	17	-	mV/°C
V _{GS(th)} temperature coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA	-	-4.3	-	
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1	-	2.2	V
Gate-source leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = +16 / -12 \text{ V}$	-	-	100	nA
Zero gate voltage drain current		V _{DS} = 30 V, V _{GS} = 0 V	-	-	1	
	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V, T _J = 70 °C			15	μA
On-state drain current ^a	I _{D(on)}	$V_{DS} \ge 10 \text{ V}, V_{GS} = 10 \text{ V}$	40	-	-	Α
Drain-source on-state resistance ^a	Б	V _{GS} = 10 V, I _D = 15 A	-	0.00100	0.00120	
	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	0.00145	0.00185	Ω
Forward transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 15 A	-	95	-	S
Dynamic ^b						
Input capacitance	C _{iss}		-	4460	-	pF
Output capacitance	C _{oss}	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	-	1615	-	
Reverse transfer capacitance	C _{rss}		-	202	-	
Total gate charge	Qg	V _{DS} = 15 V, V _{GS} = 10 V, I _D = 10 A	-	61.5	93	nC
			-	28.7	44	
Gate-source charge	Q _{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 10 \text{ A}$	-	10	-	
Gate-drain charge	Q_{gd}		-	5.8	-	
Gate resistance	R _g	f = 1 MHz	0.2	0.7	1.3	Ω
Turn-on delay time	t _{d(on)}		-	12	24	
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega, I_D \cong 10 \text{ A},$	-	21	42	•
Turn-off delay time	t _{d(off)}	$V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$	-	26	52	
Fall time	t _f		-	10	20	
Turn-on delay time	t _{d(on)}		-	25	50	ns
Rise time	t _r	$V_{DD} = 15 \text{ V}, R_L = 1.5 \Omega, I_D \cong 10 \text{ A},$	-	39	78	- - -
Turn-off delay time	t _{d(off)}	V_{GEN} = 4.5 V, R_g = 1 Ω	-	30	60	
Fall time	t _f		-	21	42	
Drain-Source Body Diode Characteristics						
Continuous source-drain diode current	I _S	T _C = 25 °C	-	-	59.7	۸
Pulse diode forward current	I _{SM}			-	300	A
Body diode voltage	V_{SD}	$I_S = 5 A, V_{GS} = 0 V$	-	0.72	1.1	V
Body diode reverse recovery time	t _{rr}		-	16	112	ns
Body diode reverse recovery charge	Q _{rr}	I _F = 15 A, di/dt = 100 A/μs,	-	66	132	nC
Reverse recovery fall time	t _a	T _J = 25 °C	-	25	-	
Reverse recovery rise time	t _b		-	31	-	ns

Notes

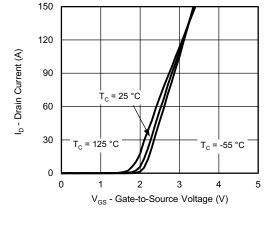
- a. Pulse test; pulse width $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing
- c. T_{CASE} = 25 °C. Expected voltage stress during 100 % UIS test. Production datalog is not available

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

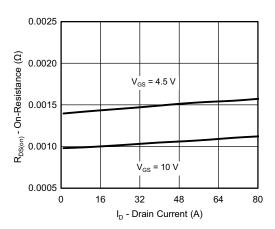




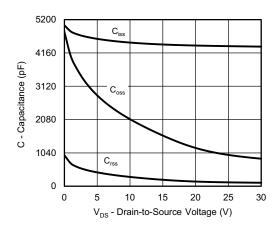
Output Characteristics



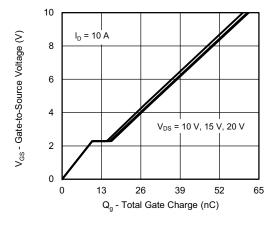
Transfer Characteristics



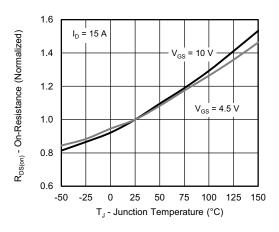
On-Resistance vs. Drain Current and Gate Voltage



Capacitance

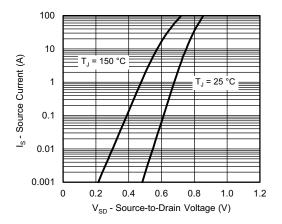


Gate Charge

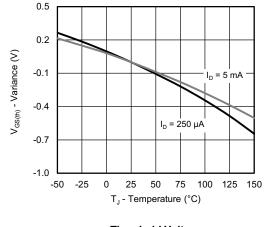


On-Resistance vs. Junction Temperature

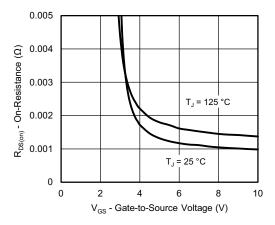




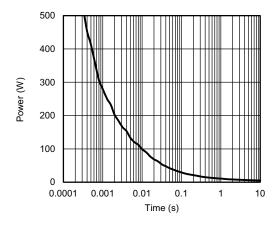
Source-Drain Diode Forward Voltage



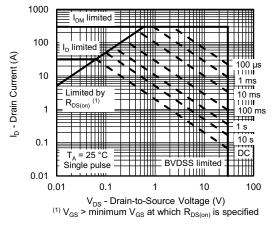
Threshold Voltage



On-Resistance vs. Gate-to-Source Voltage

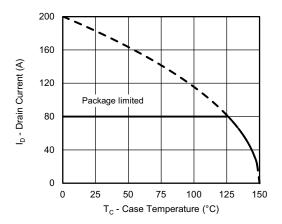


Single Pulse Power, Junction-to-Ambient

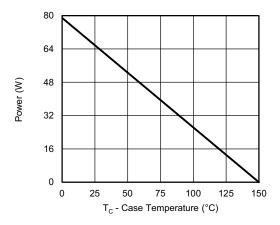


Safe Operating Area, Junction-to-Ambient

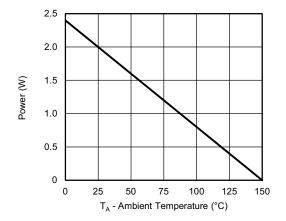




Current Derating a





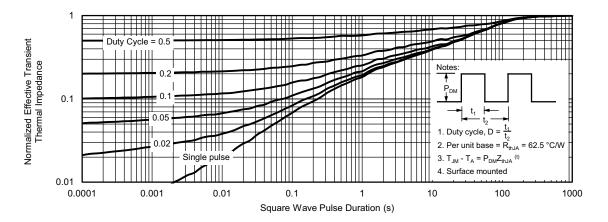


Power, Junction-to-Ambient

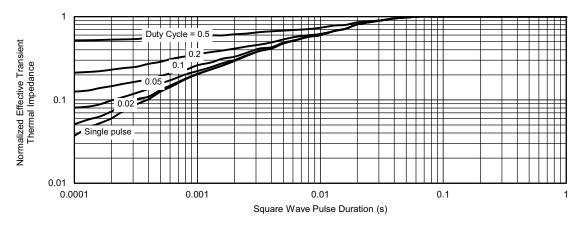
Note

a. The power dissipation P_D is based on T_J max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package / tape drawings, part marking, and reliability data, see www.vishay.com/ppg?75882.



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